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February 1997



General Description

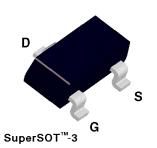
FAIRCHILD

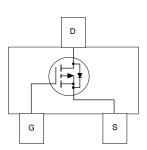
SEMICONDUCTOR TM

These P -Channel logic level enhancement mode power field effect transistors are produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. These devices are particularly suited for low voltage applications such as notebook computer power management, portable electronics, and other battery powered circuits where fast high-side switching, and low in-line power loss are needed in a very small outline surface mount package.

Features

- $\begin{array}{c|c} \bullet & \text{-0.9 A, -30 V. } \mathsf{R}_{\mathsf{DS(ON)}} = 0.5 \; \Omega @ \mathsf{V}_\mathsf{GS} = \text{-4.5 V} \\ \mathsf{R}_{\mathsf{DS(ON)}} = 0.3 \; \Omega @ \mathsf{V}_\mathsf{GS} = \text{-10 V.} \end{array}$
- Industry standard outline SOT-23 surface mount package using proprietary SuperSOT[™]-3 design for superior thermal and electrical capabilities.
- High density cell design for extremely low R_{DS(ON)}.
- Exceptional on-resistance and maximum DC current capability.





Absolute Maximum Ratings $T_{A} = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | | NDS352AP | Units |
|----------------------------------|---|-----------|------------|-------|
| V _{DSS} | Drain-Source Voltage | | -30 | V |
| V _{GSS} | Gate-Source Voltage - Continuous | | ±20 | V |
| I _D | Maximum Drain Current - Continuous | (Note 1a) | ±0.9 | A |
| - Pulsed | | | ±10 | |
| P _D | Maximum Power Dissipation | (Note 1a) | 0.5 | W |
| | | (Note 1b) | 0.46 | |
| Г _Ј ,Т _{STG} | Operating and Storage Temperature Range | e | -55 to 150 | °C |
| THERMA | L CHARACTERISTICS | | | |
| ۲ _{өла} | Thermal Resistance, Junction-to-Ambient (Note 1a) | | 250 | |
| ۲ _{өлс} | Thermal Resistance, Junction-to-Case | (Note 1) | 75 | °C/W |

| Symbol | Parameter | Conditions | | Min | Тур | Max | Units |
|----------------------|-----------------------------------|---|-----------------------|------|------|------|-------|
| OFF CHA | RACTERISTICS | | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 V, I_{D} = -250 \mu A$ | | -30 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -24 V, V_{GS} = 0 V$ | | | | -1 | μA |
| | | | T _J =125°C | | | -10 | μA |
| GSSF | Gate - Body Leakage, Forward | $V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$ | · | | | 100 | nA |
| GSSR | Gate - Body Leakage, Reverse | $V_{\rm GS} = -20 \text{ V}, V_{\rm DS} = 0 \text{ V}$ | | | | -100 | nA |
| ON CHAR | ACTERISTICS (Note 2) | | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$ | | -0.8 | -1.7 | -2.5 | V |
| CO(al) | | | T _J =125°C | -0.5 | -1.4 | -2.2 | 1 |
| R _{DS(ON)} | Static Drain-Source On-Resistance | $V_{GS} = -4.5 \text{ V}, \text{ I}_{D} = -0.9 \text{ A}$ | | | 0.45 | 0.5 | Ω |
| | | | T _J =125°C | | 0.65 | 0.7 | 1 |
| | | $V_{GS} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ A}$ | | | 0.25 | 0.3 |] |
| D(ON) | On-State Drain Current | V _{GS} = -4.5 V, V _{DS} = -5 V | | -2 | | | Α |
| 9 _{FS} | Forward Transconductance | $V_{DS} = -5 V, I_{D} = -0.9 A$ | | | 1.9 | | S |
| DYNAMIC | CHARACTERISTICS | | | | | | |
| C _{iss} | Input Capacitance | $V_{DS} = -15 \text{ V}, \text{ V}_{GS} = 0 \text{ V},$ f = 1.0 MHz | | | 135 | | pF |
| C _{oss} | Output Capacitance | | | | 88 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | | 40 | | pF |
| SWITCHIN | IG CHARACTERISTICS (Note 2) | | | | | | |
| d(on) | Turn - On Delay Time | $V_{DD} = -6 \text{ V}, \text{ I}_{D} = -1 \text{ A},$ $V_{GS} = -4.5 \text{ V}, \text{ R}_{GEN} = 6 \Omega$ | | | 5 | 10 | ns |
| r | Turn - On Rise Time | | | | 17 | 30 | ns |
| d(off) | Turn - Off Delay Time | | | | 35 | 70 | ns |
| f | Turn - Off Fall Time | | | | 30 | 60 | ns |
| d(on) | Turn - On Delay Time | $V_{DD} = -10 \text{ V}, \text{ I}_{D} = -1 \text{ A},$ $V_{GS} = -10 \text{ V}, \text{ R}_{GEN} = 50 \Omega$ | | | 8 | 15 | ns |
| r | Turn - On Rise Time | | | | 16 | 30 | ns |
| d(off) | Turn - Off Delay Time | | | | 35 | 90 | ns |
| f | Turn - Off Fall Time | | | | 30 | 90 | ns |
| J [°] | Total Gate Charge | $V_{DS} = -10 \text{ V}, \text{ I}_{D} = -0.9 \text{ A},$ $V_{GS} = -4.5 \text{ V}$ | | | 2 | 3 | nC |
| ي ک ^{ور} | Gate-Source Charge | | | | 0.5 | | nC |
| 2 _{gd} | Gate-Drain Charge | | | | 1 | | nC |

| Electrical Characteristics (T _A = 25°C unless otherwise noted) | | | | | | |
|---|---|--|-----|------|-------|-------|
| Symbol | Parameter | Conditions | Min | Тур | Max | Units |
| DRAIN-SO | URCE DIODE CHARACTERISTICS AND M | AXIMUM RATINGS | | • | • | |
| I _s | Maximum Continuous Source Current | | | | -0.42 | А |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | | | -10 | А |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 V, I_{S} = -0.42 \text{ (Note 2)}$ | | -0.8 | -1.2 | V |

Notes:

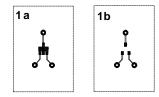
1. R_{Bub} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{Bub} is guaranteed by design while R_{Bub} is determined by the user's board design.

$$P_D(t) = \frac{T_J - T_A}{R_{\theta J A}(t)} = \frac{T_J - T_A}{R_{\theta J C} + R_{\theta C A}(t)} = I_D^2(t) \times R_{DS(ON) \otimes T_J}$$

Typical $\rm R_{\rm 6JA}$ using the board layouts shown below on 4.5"x5" FR-4 PCB in a still air environment:

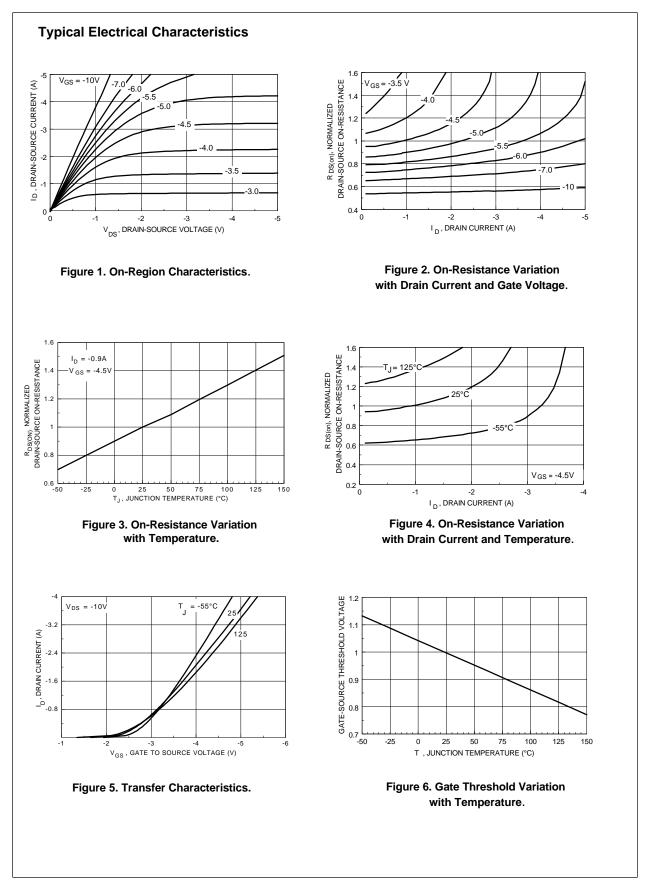
a. 250°C/W when mounted on a 0.02 \mbox{in}^2 pad of 2oz copper.



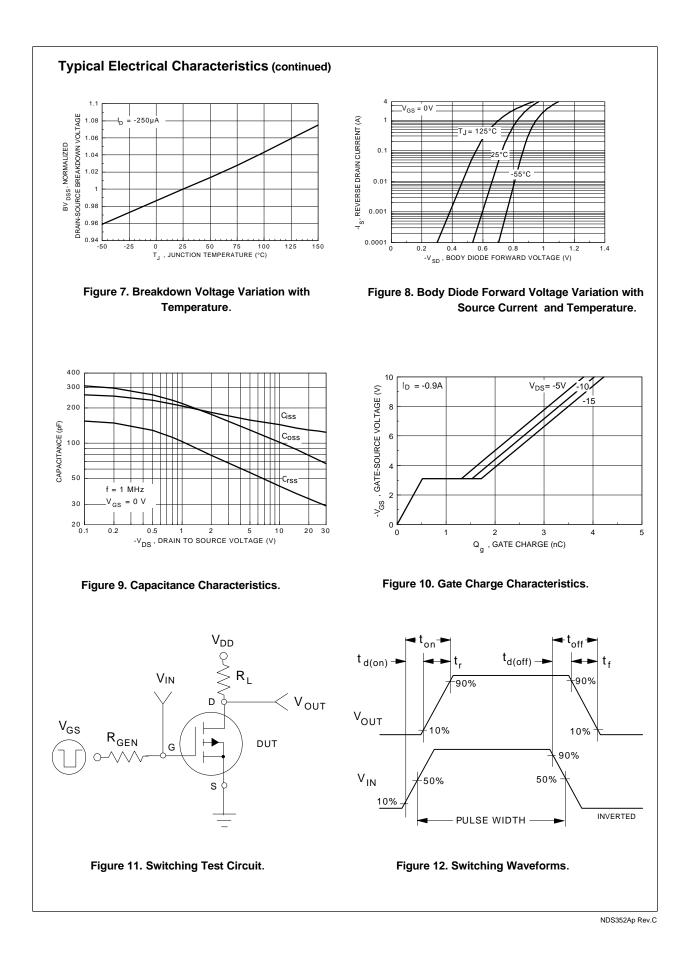


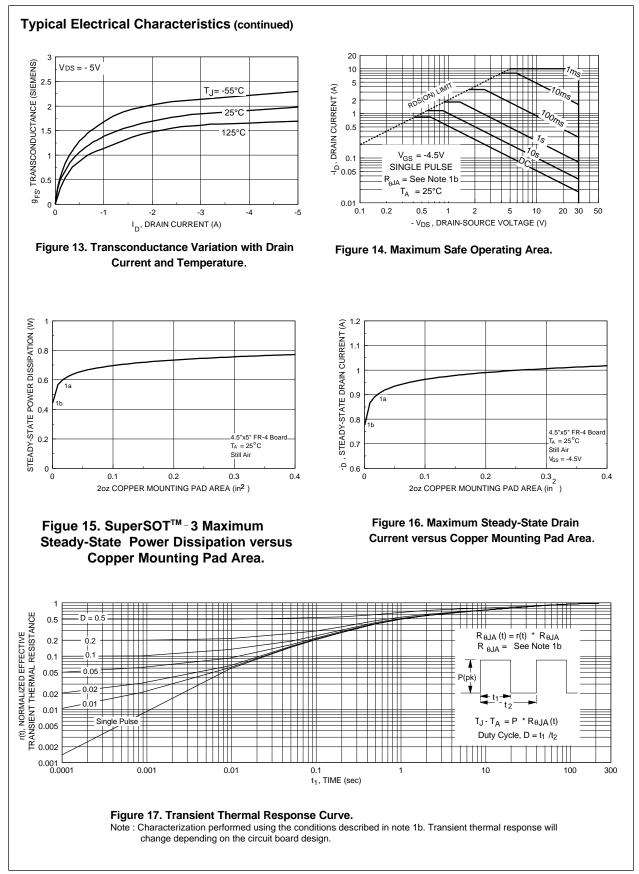
Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width \leq 300µs, Duty Cycle \leq 2.0%.



NDS352AP Rev.C





NDS352Ap Rev.C

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